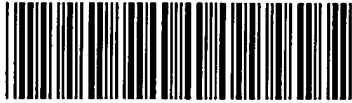


**Search Notes**

Application/Control No.

10/766,910

Examiner

Len Tran

Applicant(s)/Patent under  
Reexamination

YAMANE ET AL.

Art Unit

1725

**SEARCHED**

Class	Subclass	Date	Examiner
164	466	5/13/2005	LT
	502		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST and Palm	5/13/2005	LT